

flowSOL0-SiC	1200V / 45mΩ
Features <ul style="list-style-type: none"> • Rohm™ Silicon Carbide Power MOSFET • Rohm™ Silicon Carbide Power Schottky Diode • Dual Boost Topology • Ultra Low Inductance with Integrated DC-capacitors • Extremely Fast Switching with No "Tail" Current • Solderless Press-fit Mounting Technology 	
Target Applications <ul style="list-style-type: none"> • Solar Inverter • UPS • DC-DC 	
Types <ul style="list-style-type: none"> • 10-PZ12B2A045MR-M330L18Y 	

Maximum Ratings

T_j=25°C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Boost - Silicon Carbide Power MOSFET				
Drain to source breakdown voltage	V _{DS}		1200	V
DC drain current	I _D	T _j =T _j max T _h =80°C	32	A
Pulsed drain current	I _{Dpulse}	t _p limited by T _j max T _c =25°C		A
Power dissipation	P _{tot}	T _j =T _j max T _h =80°C	50	W
Gate-source peak voltage	V _{GS}		+22 -6	V
Maximum junction temperature	T _j max		150	°C
Protection Diode				
Peak repetitive reverse voltage	V _{RRM}		1600	V
DC forward current	I _F	T _j =T _j max T _h =80°C	30	A
Repetitive peak forward current	I _{FRM}	t _p limited by T _j max	90	A
Power dissipation per diode	P _{tot}	T _j =T _j max T _h =80°C	42	W
Maximum junction temperature	T _j max		150	°C

Maximum Ratings

T_j=25°C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
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Boost - Silicon Carbide Power Schottky Diode

Peak repetitive reverse voltage	V _{RRM}		1200	V
DC forward current	I _F	T _j =T _j max T _h =80°C	40	A
Repetitive peak forward current	I _{FRM}	t _p limited by T _j max		A
Power dissipation per diode	P _{tot}	T _j =T _j max T _h =80°C	70	W
Maximum junction temperature	T _j max		150	°C

Thermal Properties

Storage temperature	T _{stg}		-40...+150	°C
Operation temperature under switching condition	T _{op}		-40...(T _j max-25)	°C

Insulation Properties

Insulation voltage	V _{is}	t=2s	DC voltage	4000	V
Creepage distance				12.7	mm
Clearance				12.7	mm

Characteristic Values

Parameter	Symbol	Conditions				Value			Unit
		V_{GE} [V] or V_{GS} [V]	V_r [V] or V_{CE} [V] or V_{DS} [V]	I_c [A] or I_F [A] or I_D [A]	T_j	Min	Typ	Max	
Boost - Silicon Carbide Power MOSFET									
Static drain-source ON resistance	$R_{ds(on)}$		18	20	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		45	60	$\text{m}\Omega$
Gate threshold voltage	$V_{(GS)th}$	$V_{DS}=V_{GS}$		0.0088	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1.7		3.7	V
Gate to source leakage current	I_{gss}		22 -6	0	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0.2	-0.2	μA
Zero gate voltage drain current	I_{dss}		0	1200	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			0.02	mA
Turn on delay time	$t_{d(ON)}$	$R_{gon}=8\Omega$ $R_{goff}=8\Omega$	16	700	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	35			
Rise time	t_r								
Turn off delay time	$t_{d(OFF)}$								
Fall time	t_f								
Turn-on energy loss per pulse	E_{on}								
Turn-off energy loss per pulse	E_{off}								
Total gate charge	Q_g					$T_j=25^\circ\text{C}$			nC
Gate to source charge	Q_{gs}								
Gate to drain charge	Q_{gd}								
Input capacitance	C_{iss}	$f=1\text{MHz}$	0	25	$T_j=25^\circ\text{C}$	4400			pF
Output capacitance	C_{oss}								
Reverse transfer capacitance	C_{iss}								
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal foil thickness=76um Kunze KU-ALF5				1.4			K/W
Thermal resistance chip to case per chip	R_{thJC}								
Protection Diode									
Diode forward voltage	V_F			30	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1	1.15 1.11	1.6	V
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal foil thickness=76um Kunze KU-ALF5				1.7			K/W
Thermal resistance chip to case per chip	R_{thJC}								
Boost - Silicon Carbide Power Schottky Diode									
Diode forward voltage	V_F			40	$T_j=25^\circ\text{C}$ $T_j=150^\circ\text{C}$		1.5 1.9	1.7	V
Reverse leakage current	I_r		1200		$T_j=25^\circ\text{C}$ $T_j=150^\circ\text{C}$		40 320	800	μA
Peak reverse recovery current	I_{RRM}								A
Reverse recovery time	t_{rr}								
Reverse recovered charge	Q_{rr}								
Peak rate of fall of recovery current	$d(i/\text{rec})/\text{dt}$								
Reverse recovery energy	E_{rec}								
Thermal resistance chip to heatsink per chip	R_{thJH}							1	K/W
Thermal resistance chip to case per chip	R_{thJC}							N/A	
DC link Capacitor									
Capacitance	C				$T_j=25^\circ\text{C}$	80	100	120	nF
Thermistor									
Rated resistance	R_{25} R_{125}				$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	20.9 644	22 750	23.1 872	$\text{k}\Omega$ Ω
Operating current	I				$T_j=25^\circ\text{C}$			0.3	mA
Power dissipation	P				$T_j=25^\circ\text{C}$			200	mW
B-value	$B_{(25/50)}$				$T_j=25^\circ\text{C}$		3950		K

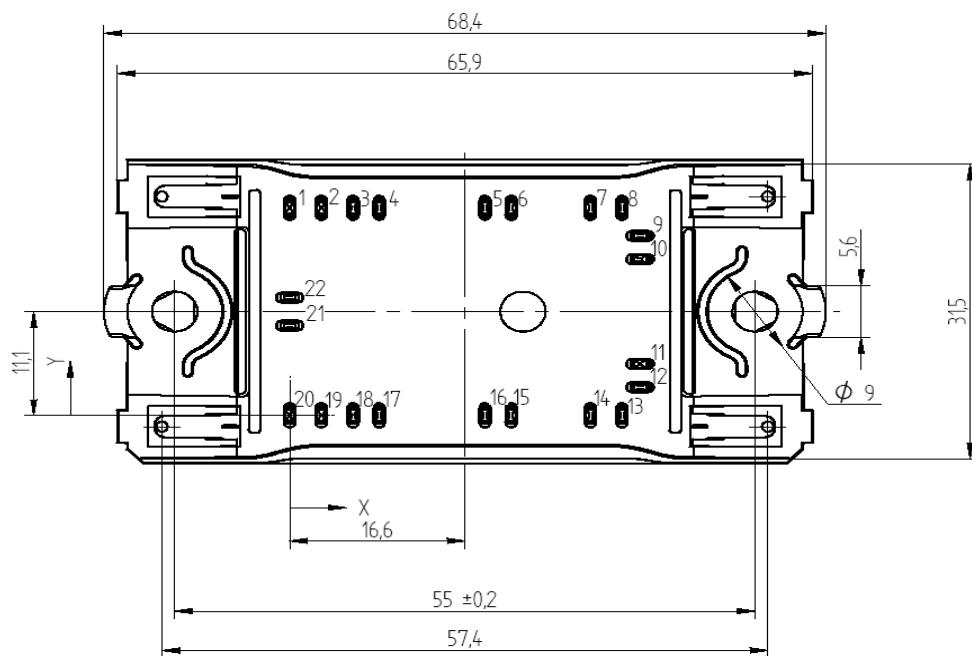
Ordering Code and Marking - Outline - Pinout

Ordering Code & Marking

Version	Ordering Code	in DataMatrix as	in packaging barcode as
without thermal paste 12mm housing	10-PZ12B2A045MR-M330L18Y	M330L18Y	M330L18Y

Outline

Pin table		
Pin	X	Y
1	0	22,2
2	3	22,2
3	6	22,2
4	8,5	22,2
5	18,5	22,2
6	21	22,2
7	28,5	22,2
8	31,5	22,2
9	33,2	19,2
10	33,2	16,7
11	33,2	5,5
12	33,2	3
13	31,5	0
14	28,5	0
15	21	0
16	18,5	0
17	8,5	0
18	6	0
19	3	0
20	0	0
21	0	9,5
22	0	12,6



Pinout

